IRF830

Power Field Effect Transistor

N−Channel Enhancement Mode Silicon Gate TMOS

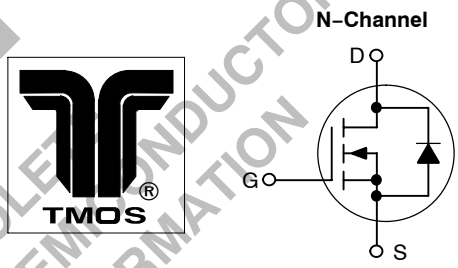
This TMOS Power FET is designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

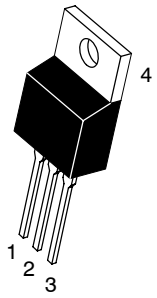
- Silicon Gate for Fast Switching Speeds
- Low $R_{DS(on)}$ to Minimize On−Losses, Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- Source−to−Drain Diode Characterized for Use with Inductive Loads

ON Semiconductor

http://onsemi.com

TMOS POWER FET
4.5 AMPERES, 500 VOLTS
$R_{DS(on)}$ = 1.5 Ω





TO−220AB
CASE 221A
STYLE 5

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain−Source Voltage	V_{DSS}	500	Vdc
Drain−Gate Voltage (R_{GS} = 1.0 MΩ)	V_{DGR}	500	Vdc
Gate−Source Voltage	V_{GS}	±20	Vdc
Drain Current Continuous, T_C = 25°C T_C = 100°C Peak, T_C = 25°C	I_D	 4.5 3.0 18	Adc
Total Power Dissipation @ T_C = 25°C Derate above 25°C	P_D	75 0.6	Watts W/°C
Operating and Storage Temperature Range	T_J, T_{stg}	−55 to 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance — Junction−to−Case — Junction−to−Ambient	 $R_{\theta JC}$ $R_{\theta JA}$	 1.67 62.5	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8″ from Case for 5 Seconds	T_L	300	°C

PIN ASSIGNMENT	
1	Gate
2	Drain
3	Source
4	Drain

ORDERING INFORMATION

Device	Package	Shipping
IRF830	TO−220AB	50 Units/Rail

See the MTM4N45 Data Sheet for a complete set of design curves for the product on this data sheet. Design curves of the MTP4N45 are applicable for this product.

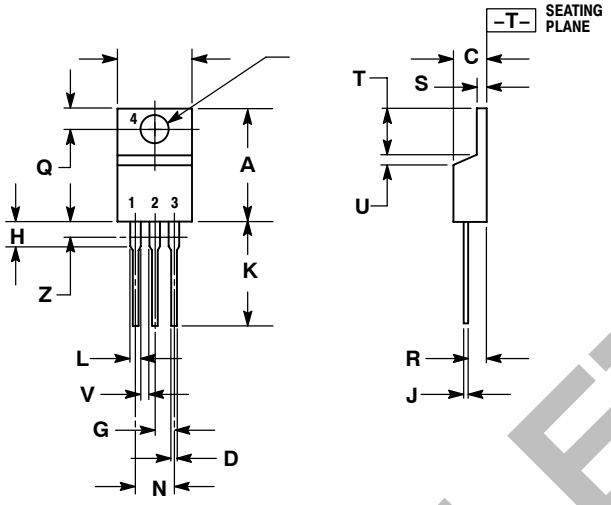
ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Max	Unit
OFF CHARACTERISTICS					
Drain−to−Source Breakdown Voltage (V_{GS} = 0 Vdc, I_D = 0.25 mAdc)		$V_{(BR)DSS}$	500	—	Vdc
Zero Gate Voltage Drain Current (V_{DS} = Rated V_{DSS}, V_{GS} = 0 Vdc) (V_{DS} = 0.8 Rated V_{DSS}, V_{GS} = 0 Vdc, T_J = 125°C)		I_{DSS}	— —	0.2 1.0	mAdc
Gate−Body Leakage Current, Forward (V_{GSF} = 20 Vdc, V_{DS} = 0)		$I_{GSS(f)}$	—	100	nAdc
Gate−Body Leakage Current, Reverse (V_{GSR} = 20 Vdc, V_{DS} = 0)		$I_{GSS(r)}$	—	100	nAdc
ON CHARACTERISTICS (1)					
Gate Threshold Voltage (V_{DS} = V_{GS}, I_D = 0.25 mA)		$V_{GS(th)}$	2.0	4.0	Vdc
Static Drain−to−Source On−Resistance (V_{GS} = 10 Vdc, I_D = 2.5 Adc)		$R_{DS(on)}$	—	1.5	Ohm
On−State Drain Current (V_{GS} = 10 V) (V_{DS} ≥ 6.75 Vdc)		$I_{D(on)}$	4.5	—	Adc
Forward Transconductance (V_{DS} ≥ 6.75 Vdc, I_D = 2.5 Adc)		g_{FS}	2.5	—	mhos
DYNAMIC CHARACTERISTICS					
Input Capacitance	(V_{DS} = 25 Vdc, V_{GS} = 0 Vdc, f = 1.0 MHz)	C_{iss}	—	800	pF
Output Capacitance		C_{oss}	—	200	
Reverse Transfer Capacitance		C_{rss}	—	60	
SWITCHING CHARACTERISTICS (1)					
Turn−On Delay Time	(V_{DD} = 200 Vdc, I_D = 2.5 Apk, R_G = 15 Ω)	$t_{d(on)}$	—	30	ns
Rise Time		t_r	—	30	
Turn−Off Delay Time		$t_{d(off)}$	—	55	
Fall Time		t_f	—	30	
Total Gate Charge	(V_{DS} = 0.8 Rated V_{DSS}, V_{GS} = 10 Vdc, I_D = Rated I_D)	Q_g	22 (Typ)	30	nC
Gate−Source Charge		Q_{gs}	12 (Typ)	—	
Gate−Drain Charge		Q_{gd}	10 (Typ)	—	
SOURCE−DRAIN DIODE CHARACTERISTICS (1)					
Forward On−Voltage	(I_S = Rated I_D, V_{GS} = 0)	V_{SD}	1.1 (Typ)	1.6	Vdc
Forward Turn−On Time		t_{on}	Limited by stray inductance		
Reverse Recovery Time		t_{rr}	450 (Typ)	—	ns
INTERNAL PACKAGE INDUCTANCE					
Internal Drain Inductance (Measured from the contact screw on tab to center of die) (Measured from the drain lead 0.25″ from package to center of die)		L_D	 3.5 (Typ) 4.5 (Typ)	 — —	nH
Internal Source Inductance (Measured from the source lead 0.25″ from package to source bond pad)		L_S	7.5 (Typ)	—	

(1) Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

PACKAGE DIMENSIONS

TO−220AB
CASE 221A−09
ISSUE Z



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
A	0.570	0.620	14.48	15.75
B	0.380	0.405	9.66	10.28
C	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
H	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045	---	1.15	---
Z	---	0.080	---	2.04

STYLE 5:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

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PUBLICATION ORDERING INFORMATION

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